



Vishay Siliconix

N-Channel 20-V (D-S), 175 °C MOSFET

PRODUCT SUMMARY					
V _{DS} (V)	$r_{DS(on)}\left(\Omega\right)$	$r_{DS(on)}(\Omega)$ $I_{D}(A)^{a}$			
20	0.0033 at V _{GS} = 10 V	40	30 nC		
	0.0044 at V _{GS} = 4.5 V	40	30 110		

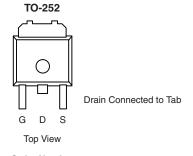
FEATURES

- TrenchFET® Power MOSFET
- 100 % R_g Tested

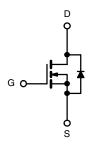


APPLICATIONS

Server



Order Number: SUD40N02-3m3P-E3 (Lead (Pb)-free)



N-Channel MOSFET

ABSOLUTE MAXIMUM RATINGS	$T_A = 25 ^{\circ}C$, unles	s otherwise no	oted		
Parameter		Symbol	Limit	Unit	
Drain-Source Voltage	V_{DS}	20	V		
Gate-Source Voltage		V_{GS}			± 20
	T _C = 25 °C		40 ^a		
Continuous Drain Current (T _{.I} = 150 °C)	T _C = 100 °C	I _D	40 ^a		
Continuous Diain Current (1) = 150 C)	T _A = 25 °C		24.4 ^b		
	T _A = 100 °C	-	17.2 ^b	Α	
Pulsed Drain Current		I _{DM}	100		
Continuous Source-Drain Diode Current	T _C = 25 °C	I.	40 ^a		
Continuous Source-Diam Diode Current	T _A = 25 °C	I _S	2.8 ^b		
	T _C = 25 °C		79	W	
Maximum Power Dissipation	T _C = 100 °C	ь	39.5		
	T _A = 25 °C	P_{D}	3.3 ^b	VV	
	T _A = 100 °C		1.6 ^b		
Operating Junction and Storage Temperature Ra	T _J , T _{stg}	- 55 to 175	°C		

THERMAL RESISTANCE RATINGS						
Parameter		Symbol	Typical	Maximum	Unit	
Maximum Junction-to-Ambient ^b	Steady State	R_{thJA}	37	45	°C/W	
Maximum Junction-to-Case	Steady State	R_{thJC}	1.5	1.9] 0/**	

Notes:

a. Package limited.

b. Surface Mounted on 1" x 1" FR4 board.

SUD40N02-3m3P

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SPECIFICATIONS $T_J = 25 ^{\circ}C$	SPECIFICATIONS T _J = 25 °C, unless otherwise noted								
Parameter	Symbol	Test Conditions	Min.	Тур.	Max.	Unit			
Static									
Drain-Source Breakdown Voltage	V _{DS}	$V_{GS} = 0 \text{ V}, I_{D} = 250 \mu\text{A}$	20			V			
V _{DS} Temperature Coefficient	$\Delta V_{DS}/T_{J}$	I _D = 250 μA		21		mV/°C			
V _{GS(th)} Temperature Coefficient	$\Delta V_{GS(th)}/T_J$	I _D = 250 μA		- 6.9					
Gate-Source Threshold Voltage	V _{GS(th)}	$V_{DS} = V_{GS}, I_{D} = 250 \mu\text{A}$	1		3	V			
Gate-Source Leakage	I _{GSS}	$V_{DS} = 0 \text{ V}, V_{GS} = \pm 20 \text{ V}$			± 100	nA			
Zero Gate Voltage Drain Current	I _{DSS}	$V_{DS} = 20 \text{ V}, V_{GS} = 0 \text{ V}$ $V_{DS} = 20 \text{ V}, V_{GS} = 0 \text{ V}, T_{J} = 100 ^{\circ}\text{C}$			1 20	μΑ			
On-State Drain Current ^a	I _{D(on)}	$V_{DS} = 20 \text{ V}, V_{GS} = 0 \text{ V}, T_{J} = 100 \text{ C}$ $V_{DS} \ge 5 \text{ V}, V_{GS} = 10 \text{ V}$	30		20	Α			
On Grand Brain Garrent	ال (on)	$V_{GS} = 10 \text{ V}, I_{D} = 20 \text{ A}$		0.0027	0.0033	 ^			
Drain-Source On-State Resistance ^a	r _{DS(on)}	$V_{GS} = 4.5 \text{ V}, I_D = 20 \text{ A}$		0.0027	0.0044	Ω			
Forward Transconductance ^a	9 _{fs}	V _{DS} = 15 V, I _D = 20 A		100		S			
Dynamic ^b		50 5				l			
Input Capacitance	C _{iss}			6520		pF			
Output Capacitance	C _{oss}	V _{DS} = 10 V, V _{GS} = 0 V, f = 1 MHz		1430					
Reverse Transfer Capacitance	C _{rss}	30 4 00		770					
Total Gate Charge		V _{DS} = 10 V, V _{GS} = 10 V, I _D = 50 A		105	160	nC			
Total Gate Charge	Q_g	V _{DS} = 10 V, V _{GS} = 4.5 V, I _D = 50 A		50	75				
Gate-Source Charge	Q _{qs} V _D			17					
Gate-Drain Charge	Q_{gd}			14					
Gate Resistance	R_{g}	f = 1 MHz		1.2	1.9	Ω			
Turn-On Delay Time	t _{d(on)}			40	60	ns			
Rise Time	t _r	$V_{DD} = 10 \text{ V}, R_{L} = 0.2 \Omega$		30	45				
Turn-Off Delay Time	t _{d(off)}	$I_D \cong 50 \text{ A}, V_{GEN} = 4.5 \text{ V}, R_g = 1 \Omega$		67	101				
Fall Time	t _f			33	50				
Turn-On Delay Time	t _{d(on)}			13	20				
Rise Time	t _r	$V_{DD} = 10 \text{ V}, R_1 = 0.2 \Omega$		7	11				
Turn-Off Delay Time	t _{d(off)}	$I_D \cong 50 \text{ A}, V_{GEN} = 10 \text{ V}, R_g = 1 \Omega$		40	60				
Fall Time	t _f			9	14				
Drain-Source Body Diode Characteris	tics								
Continuous Source-Drain Diode Current	I _S	T _C = 25 °C			40	A			
Pulse Diode Forward Current ^a	I _{SM}				100				
Body Diode Voltage	V_{SD}	I _S = 20 A		0.81	1.2	V			
Body Diode Reverse Recovery Time	t _{rr}			38	57	ns			
Body Diode Reverse Recovery Charge	Q _{rr}			34	51	nC			
Reverse Recovery Fall Time	ta	$I_F = 50 \text{ A}, \text{ di/dt} = 100 \text{ A/}\mu\text{s}, T_J = 25 ^{\circ}\text{C}$		18		ns			
Reverse Recovery Rise Time	t _b			20					

Notes:

Stresses beyond those listed under "Absolute Maximum Ratings" may cause permanent damage to the device. These are stress ratings only, and functional operation of the device at these or any other conditions beyond those indicated in the operational sections of the specifications is not implied. Exposure to absolute maximum rating conditions for extended periods may affect device reliability.

a. Pulse test; pulse width \leq 300 $\mu s,$ duty cycle \leq 2 %.

b. Guaranteed by design, not subject to production testing.

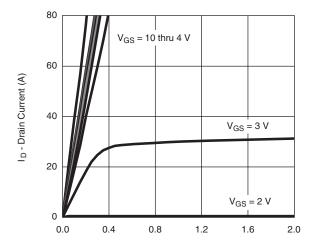
3.0



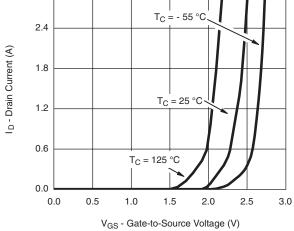


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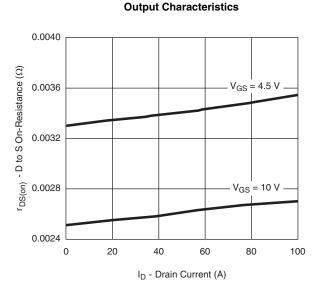
TYPICAL CHARACTERISTICS 25 °C, unless otherwise noted



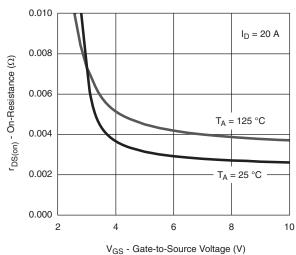
V_{DS} - Drain-to-Source Voltage (V)



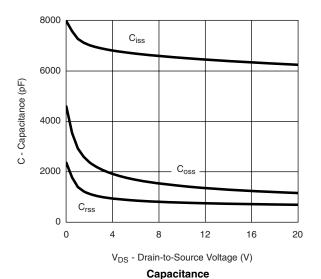
Transfer Characteristics

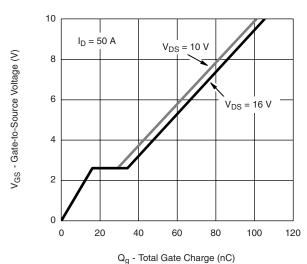


On-Resistance vs. Drain Current



On-Resistance vs. V_{GS} vs. Temperature



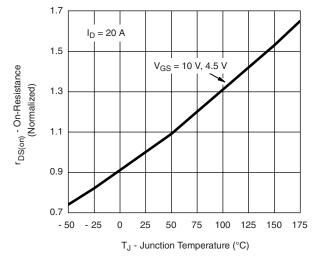


Gate Charge

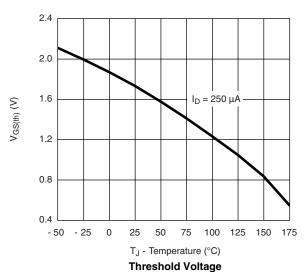
SUD40N02-3m3P

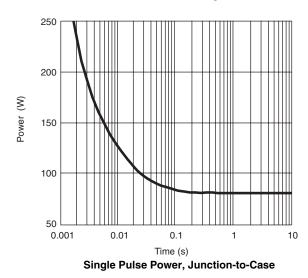
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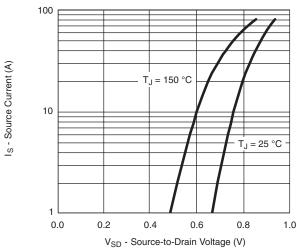
TYPICAL CHARACTERISTICS 25 °C, unless otherwise noted



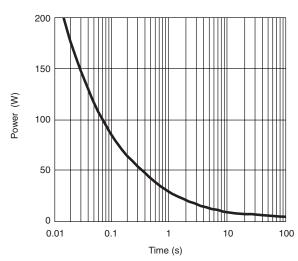
On-Resistance vs. Junction Temperature



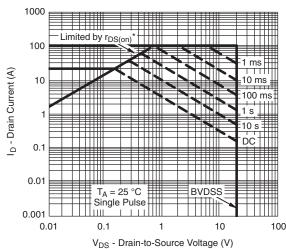




Forward Diode Voltage vs. Temperature



Single Pulse Power, Junction-to-Ambient



* V_{GS} > minimum V_{GS} at which $r_{DS(on)}$ is specified

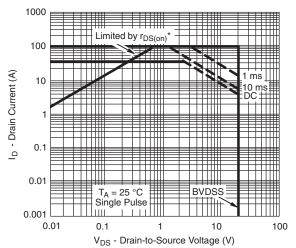
Safe Operating Area, Junction-to-Ambient





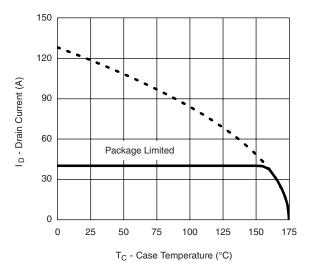
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TYPICAL CHARACTERISTICS 25 °C, unless otherwise noted

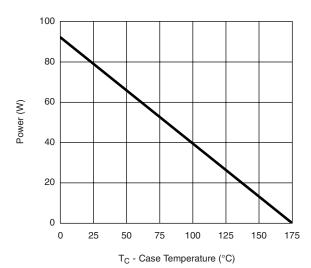


* V_{GS} > minimum V_{GS} at which $r_{DS(on)}$ is specified

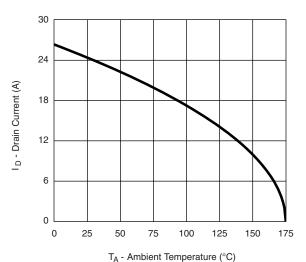
Safe Operating Area, Junction-to-Case



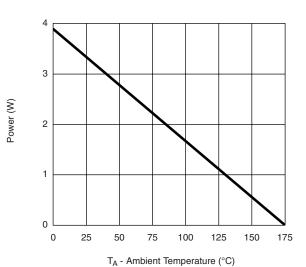
Current Derating**, Junction-to-Case



Power Derating**, Junction-to-Case



Current Derating**, Junction-to-Ambient



Power Derating**, Junction-to-Ambient

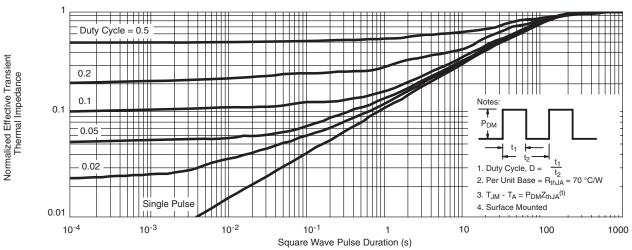
^{**} The power dissipation P_D is based on $T_{J(max)} = 175$ °C, using junction-to-case thermal resistance, and is more useful in settling the upper dissipation limit for cases where additional heatsinking is used. It is used to determine the current rating, when this rating falls below the package limit.

SUD40N02-3m3P

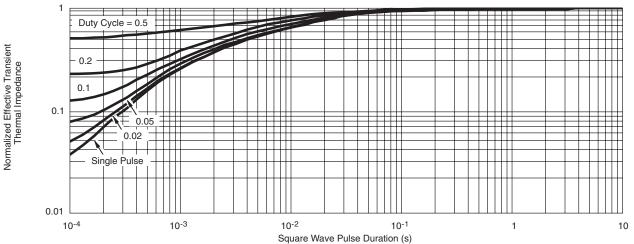
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TYPICAL CHARACTERISTICS 25 °C, unless otherwise noted



Normalized Thermal Transient Impedance, Junction-to-Ambient



Normalized Thermal Transient Impedance, Junction-to-Case

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